The Model 2820 RF Vector Signal Analyzer is a mid-performance test instrument designed for R&D and production testing of modern RF communications equipment and devices. This next-generation instrument combines state-of-the-art RF and digital signal processing (DSP) technology to measure RF test signals rapidly with high accuracy and excellent repeatability. Its compact half-rack enclosure and competitive pricing make it a cost-effective solution for many test applications. The Model 2820’s DSP-based software-defined radio (SDR) architecture and 40MHz bandwidth ensure it has the capability to measure today’s signals and also the flexibility to handle tomorrow’s. Today’s mobile phones are designed to connect to more types of devices than ever before, so they must integrate with a growing number of wireless standards. As new wireless standards emerge, the Model 2820 is engineered for easy upgrades, which extend its useful life and provide an ongoing return on investment far longer than traditional instruments.

The Model 2820’s Windows CE® operating system and intuitive graphical user interface allow users their choice of operating it via the touch-screen user interface, the front panel controls, or with a mouse. GPIB, USB, and 100Base-T Ethernet LAN ports offer a variety of options for connecting to a PC; it is LXI Class C compliant, so it’s equally easy to connect to an internal network or the Internet. Tests can be created by developing scripts using SCPI (Standard Commands for Programmable Instrumentation) commands, with IVI-COM or IVI-C drivers, or by assembling LabVIEW® building blocks.
RF Vector Signal Analyzer
400MHz to 4GHz or 6GHz

Innovative Architecture

The Model 2820's software-defined radio architecture allows it to analyze and demodulate virtually any signal up to 40MHz bandwidth without needing to upgrade hardware. This provides high flexibility in R&D and production environments and reduces capital equipment cost. Unlike traditional instrument architectures, this DSP-based SDR architecture combines the ability to measure the signals produced by current devices with the adaptability to handle signals future devices will produce, so the instrument remains productive over a longer period.

When an RF signal is input to the Model 2820, it's down-converted to an intermediate frequency (IF), digitized by a fast, high resolution analog-to-digital converter (ADC), and routed into the waveform memory. The high speed DSP analyzes and demodulates the signal waveform. That means the instrument's RF signal analysis capability is defined through DSP software rather than in hardware. The DSP can switch rapidly between various optional signal analysis personalities. Alternatively, the signal's I-Q data pairs can be output to an external PC for analysis.

A 100MHz fixed-rate ADC and a fixed-bandwidth, brick-wall, anti-alias filter combine to ensure high signal integrity by reducing alias spurs. The Digital Up/Down Converter (DUC/DDC) compresses and decompresses waveforms, which allows multiple signal sampling rates, conserves waveform memory space, and speeds signal processing. The instrument's Field-Programmable Gate Array (FPGA) supports fast triggering and high speed signal conditioning and routing.

The key components of the Model 2820's DSP-based software-defined radio architecture are optimized for high accuracy and speed while reducing instrument cost and size.

The Model 2820's software-defined radio architecture allows it to analyze and demodulate virtually any signal up to 40MHz bandwidth without needing to upgrade hardware. This provides high flexibility in R&D and production environments and reduces capital equipment cost. Unlike traditional instrument architectures, this DSP-based SDR architecture combines the ability to measure the signals produced by current devices with the adaptability to handle signals future devices will produce, so the instrument remains productive over a longer period.

When an RF signal is input to the Model 2820, it's down-converted to an intermediate frequency (IF), digitized by a fast, high resolution analog-to-digital converter (ADC), and routed into the waveform memory. The high speed DSP analyzes and demodulates the signal waveform. That means the instrument's RF signal analysis capability is defined through DSP software rather than in hardware. The DSP can switch rapidly between various optional signal analysis personalities. Alternatively, the signal's I-Q data pairs can be output to an external PC for analysis.

A 100MHz fixed-rate ADC and a fixed-bandwidth, brick-wall, anti-alias filter combine to ensure high signal integrity by reducing alias spurs. The Digital Up/Down Converter (DUC/DDC) compresses and decompresses waveforms, which allows multiple signal sampling rates, conserves waveform memory space, and speeds signal processing. The instrument's Field-Programmable Gate Array (FPGA) supports fast triggering and high speed signal conditioning and routing.

The key components of the Model 2820's DSP-based software-defined radio architecture are optimized for high accuracy and speed while reducing instrument cost and size.

The key components of the Model 2820's DSP-based software-defined radio architecture are optimized for high accuracy and speed while reducing instrument cost and size.

The key components of the Model 2820's DSP-based software-defined radio architecture are optimized for high accuracy and speed while reducing instrument cost and size.

The key components of the Model 2820's DSP-based software-defined radio architecture are optimized for high accuracy and speed while reducing instrument cost and size.
RF Vector Signal Analyzer
400MHz to 4GHz or 6GHz

Discover the Flexibility of Three Powerful Operating Modes

1. Spectrum Analyzer Mode—The Model 2820 has four multi-purpose spectrum analysis functions for measuring the most common signal parameters of RF signals.

   - The **Spectrum Analysis function** displays the RF power vs. frequency of all signals within a user-defined frequency span. A wide selection of resolution bandwidths and filter types are available to analyze the signal’s spectral characteristics. Traditional markers and marker functions are used to measure the RF signal’s parameters.

   - The **ACPR (Adjacent Channel Power Ratio) function** measures the channel power of the primary signal along with that of adjacent channels and next-adjacent channels. The channel frequency, channel bandwidth, test limits, and adjacent channels are user-definable. Each channel frequency is measured separately for high accuracy. When it’s desirable to reduce test times, users can also choose not to measure the adjacent and next-adjacent channels.

   - The **Channel Power List function** allows setting up a pre-defined list of frequencies, measurement bandwidths, and measurement times. Triggering is commonly used to synchronize the list with other instruments in a system.

   - Using the **Zero Span function**, the analyzer becomes a fixed-tuned receiver to capture and analyze signals up to 40MHz bandwidth at a fixed carrier frequency. An RF signal is demodulated and the signal power vs. time is displayed. A wide selection of bandwidths and filter types are available and an assortment of triggers can be used to capture the signal easily.

2. Vector Signal Analysis Mode—The Model 2820 is designed to be combined with a variety of signal analysis personality options for testing to the most common wireless standards, such as GSM, EDGE, W-CDMA FDD, cdmaOne, cdma2000, 802.11 WLAN, and 802.16e mobile-WiMAX. A robust set of measurements, instrument settings, and test limits are customized for each of the various standards, saving instrument configuration time and minimizing the potential for operator error. For example, an ACPR measurement for each of the standards is part of the signal analysis personality option.

3. Signal Capture Capability – The Model 2820 can receive RF signals of up to 40MHz bandwidth and store them in its 32 megasample waveform memory as I-Q data pairs. A waveform record size of up to 30 seconds can be captured at a one megasample/second sampling rate. The I-Q data can be uploaded to a PC through the GPIB, USB, or LAN interfaces for analysis or to playback with an RF vector signal generator. The signal waveform can be analyzed with PC-based software such as MATLAB, LabVIEW, or a variety of software applications from Keithley.

Use the Adjacent Channel Power Ratio function to define the test parameters and the test limits for non-standards-based signals.

Measure the key parameters of GSM and EDGE signals quickly and easily with the Model 2820-GSM option. The GSM time mask is shown here, along with the results of the signal measurement.

It’s easy to upload I-Q signal data pairs from the Model 2820 to a PC for analysis. The free Vector Signal Analyzer software application shown here can be downloaded from www.keithley.com.
High Accuracy and Repeatability
The Model 2820's RF input circuitry was designed to combine simplicity with high accuracy and repeatable performance. In R&D applications, this helps engineers determine design stability and performance consistency. In production test, high measurement accuracy and repeatability provide confidence in the quality of the devices tested. It also allows minimizing measurement guard bands, which helps increase product yields. Significant signal analysis performance specifications include:
- Absolute amplitude accuracy of ±0.6dB (typically ±0.2dB) with a 0dBm signal up to 2GHz
- ±0.2dB relative amplitude accuracy (display fidelity)
- ±0.15dB (typically ±0.07dB) amplitude repeatability
The instrument's absolute amplitude accuracy can be increased by using an external power meter to correct for frequency response variations of the analyzer and test system cables connected to the DUT test fixture interface. A power correction table feature in the Model 2820 allows users to enter amplitude offset values vs. frequency to correct all power value readings. This simplifies test system calibration and reduces operator errors.

Ultra-fast Measurements
The Model 2820 was designed to make fast measurements without compromising accuracy. Its high speed DSP controls the instrument hardware and runs all measurement operations. For example, when using the traditional spectrum analysis function, the instrument can sweep 650MHz/s in a 1kHz bandwidth, which is more than 800 times faster than traditional spectrum analyzers. And, because the Model 2820 has an all-digital IF architecture, it maintains its high speed over a wide range of resolution bandwidths and frequency spans. For example, in R&D product verification testing, this can reduce the time required for spur searching measurements from several weeks to a few days, significantly reducing time to market.

The Model 2820’s RF circuitry was optimized for speed and accuracy. The RF input section employs a patent-pending DDS (Direct Digital Synthesis) synthesizer design to switch frequencies in 1.3ms using List or Sweep modes and in 3ms using a remote SCPI command.

An electronic attenuator is used to change the Reference Level to measure rapidly over a wide dynamic range. This hardware approach has the added benefit of superior measurement repeatability over millions of cycles in production environments, unlike relatively slow mechanical attenuators, which gradually degrade after a few thousand cycles. Flexible trigger and synchronization choices further enhance measurement speed.

Ultra-fast Measurements
The Model 2820 was designed to make fast measurements without compromising accuracy. Its high speed DSP controls the instrument hardware and runs all measurement operations. For example, when using the traditional spectrum analysis function, the instrument can sweep 650MHz/s in a 1kHz bandwidth, which is more than 800 times faster than traditional spectrum analyzers. And, because the Model 2820 has an all-digital IF architecture, it maintains its high speed over a wide range of resolution bandwidths and frequency spans. For example, in R&D product verification testing, this can reduce the time required for spur searching measurements from several weeks to a few days, significantly reducing time to market.

The Model 2820’s trigger input and sync output connections simplify synchronizing its operation with that of other test instruments, such as Keithley Series 2900 RF Signal Generators, in high speed measurement applications.

The Model 2820’s Channel Power List mode supports measuring power at multiple frequencies rapidly and flexibly.

The Model 2820 captures signal data and stores it in its waveform memory, allowing the DSP to make measurements on one common set of data. Only measurement results are passed to the host microprocessor and to the PC, which ensures dramatically better measurement speed and greater consistency of measurement results when compared with measurements made with instruments using microprocessor-based architectures. For example, six signal measurements can be completed on a GSM signal in 24ms and seven measurements can be completed on a W-CDMA signal in 60ms. Switching between measurement types takes from 8ms to 29ms.
2820

RF Vector Signal Analyzer
400MHz to 4GHz or 6GHz

Complete a set of seven signal measurements in about 60ms using a Model 2920 equipped with the optional 2900-WCDMA-U, the W-CDMA FDD Uplink Signal Analysis personality.

Optimized for High Speed Production Test
Keithley’s instruments can be configured into sophisticated test systems that dramatically reduce device test times and lower capital costs compared to traditional rack-and-stack test systems. They are designed for demanding system applications requiring ultra-fast test times and accurate, repeatable measurements. Test script control and intra-instrument triggering work in cooperation to minimize bus traffic from the PC controller. Keithley’s RF test systems have reduced test times by up to 70% in RFIC production applications. Using smart instruments instead of test modules also reduces the engineering time for system test integration. This lowers schedule risk and provides greater flexibility to reconfigure the system quickly to transition new devices and equipment into production.

MIMO Test Systems
Every Model 2820 is MIMO-ready to meet the requirements of the 802.11n WiFi and 802.16e mobile-WiMAX Wave 2 multi-input, multi-output communications standards. Standard Model 2820 instruments can be configured into a ×2, ×3, or ×4 multi-input test system with the addition of a Model 2895 MIMO Synchronization Unit. The synchronization unit distributes a common LO (local oscillator), common clock, and precise trigger to all the signal analyzers connected in the system. This results in a high performance multi-input signal analysis test system with precise synchronization and low jitter between each of the signal analyzer inputs of both the RF carriers and waveform signal samplers.

Full ×4 MIMO testing is possible when this configuration is combined with the Model 2920-based multi-output signal generator test system. Imagine configuring a MIMO test system initially as a 2×2 system, then later upgrading it to 3×3 or to 4×4 by adding more Model 2820 and 2920 units. Moreover, the instruments need not be dedicated to a MIMO system. They can be configured for use either in a MIMO system or as stand-alone SISO (single input, single output) instruments by selecting the configuration in firmware and changing a few cables on the rear panel.

Through the use of test script control and intra-instrument triggering, this RF power amplifier test system based on the Model 2820 and the Model 2920 can reduce test times by up to 70%.

This 4×4 MIMO test system ensures precise synchronization and low jitter when testing WiFi, WiMAX, and other MIMO devices and equipment.
802.11n MIMO Signal Analysis Software

Model 280111 WLAN 802.11n MIMO Signal Analysis software is an industry-leading multi-channel signal analysis solution for up to four OFDM (Orthogonal Frequency Division Multiplexing) channels. It includes an extensive measurement set with a fast, easy-to-configure GUI and a SCPI command set for interfacing with test systems. It’s designed to stream data from up to four Model 2920s into the PC, analyze all of the received signals, and display the results.

Modes of Operation

**STANDARD SPECTRUM ANALYSIS MODES:** Spectrum Analyzer (power envelope amplitude vs. frequency spectrum), Zero Span (power envelope amplitude vs. time), ACPR (adjacent channel power bar chart), and channel power list.

**OPTIONAL VECTOR SIGNAL ANALYSIS MODES:** Modulation quality measurements on GSM-GPRS-EDGE, cdmaOne-cdma2000, WCDMA FDD uplink (mobile phone transmitter signals), WCDMA FDD downlink (base station transmitter signals), and WLAN (802.11a-b-g-j-n signals).

Note: All items are specifications unless otherwise noted.

**Frequency**

**FREQUENCY RANGE:** 2820-004: 400MHz to 4.0GHz 1. 2820-006: 400MHz to 6.0GHz 2.

**FREQUENCY SETTING RESOLUTION:** 0.1Hz.

**FREQUENCY ACCURACY:** Same as frequency reference + synthesizer resolution term 3.

**INTERNAL FREQUENCY REFERENCE**

**AGING RATE:** ≤1ppm/year.

**TEMPERATURE STABILITY:** ≤0.2ppm (characteristic).

**FREQUENCY REFERENCE OUTPUT**

**IMPEDANCE:** 50Ω (characteristic), AC coupled.

**REFERENCE OUTPUT SIGNAL:** 10MHz, ±7dBm ±3dB (characteristic).

**EXTERNAL FREQUENCY REFERENCE INPUT**

**VARIABLE INPUT FREQUENCY MODE:** 1 to 20MHz 5.

**AMPLITUDE:** Lock Range: 0 to +15dBm 6.

**IMPEDANCE:** 50Ω (characteristic).

**NOTES**

1. Over range operation provided: 35MHz to 4.0GHz. Performance below 400MHz is not specified.
2. Over range operation provided: 35MHz to 6.0GHz. Performance below 400MHz and above 6.0GHz is not specified.
3. Synthesizer resolution term: ≤20µHz.
4. Total variation relative to 0º to 50ºC ambient temperature range.
5. On 10Hz boundaries Freq = 1MHz + n · 10Hz. Reference accuracy: ≤±1ppm. Sine or square wave inputs acceptable.
6. For optimum phase noise, 0 to +10dBm.

Model 2820 rear panel. Note the RF input (2820-R configuration option).
RF Vector Signal Analyzer
400MHz to 4GHz or 6GHz

Spectrum Analysis Controls and Parameters

FREQUENCY SPAN: 2820-004: 200Hz to 3.6GHz \( \pm \) 0.1%, 2820-006: 200Hz to 5.6GHz \( \pm \) 0.5%. Zero span mode available.

SWEEP MODES: Continuous, single.

IF BANDWIDTH 1:
- Relative flatness over 20MHz: ±1.0dB (typical).
- Relative flatness over 4MHz: ±0.5dB (typical).
- 3dB BW: >30MHz (typical).
- 6dB BW: >5MHz (typical).

Absolute Accuracy (typical) 2:
- 3.25MHz to 400MHz: 0.2dB (characteristic).
- 400MHz ≤ Freq ≤ 2000MHz: ±0.6 (±0.2) dB.
- 2000MHz < Freq ≤ 6000MHz: ±0.8 (±0.4) dB.
- 6000MHz < Freq ≤ 6500MHz: ±5.0dB (characteristic).

REF LEVEL ACCURACY (referenced to 0dBm): +10 to −75dBm: ±0.3dB.
- −75 to −100dBm: ±0.6dB.

DISPLAY SCALE FIDELITY 1: ±0.2dB.

Sweep Modes:
- Normal, maximum, minimum, sample, power average, power average + noise correction.
- Normal, max hold, min hold, min/max hold.

AVERAGING: 1 or 1000 traces. Modes: Log, power, log group, power group, max group, min group, min/max group.

MARKERS: 4 independent markers, each with a delta marker, normal and peak modes.

Marker Amplitude Resolution: 0.01dB from front panel, 0.001dB via remote interface.

Channel Power List:
Single command to execute up to 501 power measurements.

AMPLITUDE CHANGES DUE TO PRE-AMP ON:
- ≤ ±1.0dB (characteristic).

AMPLITUDE REPEATABILITY 1: ±0.15dB (±0.07dB typical).

DISPLAYED NOISE LEVEL:
- 0.1 – 1000Hz: ±0.3dB (±0.18dB typical).

SPECTRAL AND RESIDUAL RESPONSES
- TOI (referred to the 2820 input, two 0dBm input signals and reference level = 0dBm): F ≤ 2500MHz = +35dBm (characteristic); F >2500MHz = +41dBm (characteristic).
- S01 (referred to the 2820 input, 0dBm input signals and reference level = 0dBm): +90dBm (characteristic).

RESIDUALS (reference level setting ≤–60dBm): ≤–90dBm.

I0 RELATED SPURS: ≤–55dBc.

NOTES
1. Specifications apply when autocoupled unless otherwise stated.
2. Input power at 0dBm, span = 1MHz and RBW = 0.01Hz, ±1.0dB.
3. Signal level within 50dB of top of screen, reference level 0dBm, no change in instrument state.
4. RBW switching error specified under conditions where span, RBW setting ≤3500Hz and frequency spans ≤25MHz.
5. Only applies if input attenuator is changed from autocoupled setting.
6. For repetitive CW power readings with real signal removed then reapplied for signals >0dBm above noise floor within 5 minutes.

Phase Noise

SSB PHASE NOISE, dbc/Hz:

<table>
<thead>
<tr>
<th>Carrier Frequency, GHz</th>
<th>0.1</th>
<th>1.0</th>
<th>10</th>
<th>20</th>
<th>100</th>
<th>1,000</th>
</tr>
</thead>
<tbody>
<tr>
<td>0.4</td>
<td>−106</td>
<td>−119</td>
<td>−121</td>
<td>−122</td>
<td>−121</td>
<td>−126</td>
</tr>
<tr>
<td>1.0</td>
<td>−102</td>
<td>−118</td>
<td>−119</td>
<td>−115</td>
<td>−113</td>
<td>−116</td>
</tr>
<tr>
<td>2.0</td>
<td>−97</td>
<td>−112</td>
<td>−114</td>
<td>−115</td>
<td>−113</td>
<td>−116</td>
</tr>
<tr>
<td>4.0</td>
<td>−90</td>
<td>−108</td>
<td>−111</td>
<td>−111</td>
<td>−109</td>
<td>−112</td>
</tr>
<tr>
<td>6.0</td>
<td>−89</td>
<td>−105</td>
<td>−108</td>
<td>−109</td>
<td>−107</td>
<td>−110</td>
</tr>
</tbody>
</table>

1.888.KEITHLEY (U.S. only)

www.keithley.com
2820 RF Vector Signal Analyzer
400MHz to 4GHz or 6GHz

Generator Output

**FREQUENCY RANGE:** 0–2500MHz.
**Sweep Span:** 0–2100MHz.
**Sweep Points:** 1 to 501.
**Dwell Setting:** 1ms to 1s in 1ms increments.
**Amplitude:** Fixed: –18dBm ± 5.0dB (typical).

**NOTES**
1. Over range operation provided: 325MHz to 2.7GHz. Performance below 400MHz and above 2.5GHz is not specified.
2. Over range operation provided: Maximum span: 2.375GHz. Performance below 400MHz and above 2.5GHz is not specified.

Measurement Speed Characteristics

**GENERAL PURPOSE MODE**

**SPECTRUM OR ZERO SPAN:** 19ms.
**ACPR:** 9.5ms.

**ACPR/ACLR FUNCTION**

**CENTER, UPPER AND LOWER ADJ, UPPER AND LOWER ALT:** 9.5ms.
**CENTER CHANNEL ONLY (measurement of Adj and Alt Off):** 6.0ms.

**CHANNEL POWER LIST FUNCTION**

**SINGLE FREQUENCY:** 0.9ms per point.
**FREQUENCY STEP SIZE:** 1.66ms per point.
**MAXIMUM READING RATE (minimum step width):** 100µs per point.

**GSM-EDGE PERSONALITY (GSM and GPRS Measurements)**

**PHASE ERROR, CHANNEL POWER AND TIME MASK:** 24.0ms.
**PHASE ERROR AND CHANNEL POWER FREE RUN TRIGGER:** 16.5ms (6.35ms/burst).
**PHASE ERROR AND CHANNEL POWER VIDEO TRIGGER:** 16.5ms (4.73ms/burst).

**GSM-EDGE PERSONALITY (EDGE Measurements)**

**EVM, CHANNEL POWER AND TIME MASK:** 26.3ms.
**EVM AND CHANNEL POWER:** 20.8ms (6.40ms/burst).

**CDMA PERSONALITY (cdma2000 Measurements)**

**DEMODULATION MEASUREMENT:** 50.5ms.
**ACPR:** 60.7ms (230ms).
**SPECTRUM EMISSIONS MASK:** 1.25 µms.
**OCCUPIED BANDWIDTH:** 5.19ms.

**WCDMA PERSONALITY**

**DEMODULATION MEASUREMENT:** 60.5ms.
**ACLR:** 9.35ms (208.1ms).
**SPECTRUM EMISSIONS MASK:** 129.14ms.
**OCCUPIED BANDWIDTH:** 45.14ms.

**WLAN PERSONALITY**

802.11a: 18ms
802.11b: 38ms.
802.11g: 18ms.
802.11n 2MHz: 18ms.
802.11n 40MHz: 18ms.

**MAXIMUM DISPLAY REFRESH RATE FOR A COMPLETE UPDATE OF A 640x480 PIXEL VGA SCREEN, INTERNAL DISPLAY: 50 sweeps/s (53ms/sweep).**

**DATA TRANSFER OVER LAN/TCP/IP:** Up to 6.4MB/s.

**REMOTE TRACE DATA TRANSFER**

**LAN:** 5.7ms.
**USB:** 12.7ms.
**GPIB:** 20ms.

**TIME TO SWITCH BETWEEN MEASUREMENTS**

**WITHIN GENERAL PURPOSE MODE:** 10ms.
**FROM SIGNAL ANALYSIS TO GENERAL PURPOSE MODE:** 10ms.
**FROM GENERAL PURPOSE TO SIGNAL ANALYSIS MODE:** 10ms.
**WITHIN GSM-EDGE PERSONALITY:** 10ms.
**FROM CDMA OR WCDMA PERSONALITIES, NON-DEMODULATE TO DEMODULATE:** 11ms.
**FROM CDMA OR WCDMA PERSONALITIES, DEMODULATE TO NON-DEMODULATE:** 1ms.

**NOTES**
1. Instrument preset, all settings auto coupled: 300kHz ≤ span ≤ 300MHz. In zero span, sweep time ≤ 5ms and 1MHz BW. Time is trigger to data available.
2. Fast mode on, noise correction off, range check off, randomize start off, 10µs sweep time, 4MHz BW, brickwall, display off.
3. Fast mode on, noise correction off, range check off, randomize start off, 10µs sweep time, 5.6MHz BW, RRC filter, display off.
4. 101 point list, 40µs acquisition time, 21MHz BW, brickwall, noise correction off, fast mode on, range check off, randomize start off, display off.
5. 50µs acquisition time, 21MHz BW, brickwall, noise correction off, fast mode on, range check off, randomize start off, display off.
7. 100 averages, over range check and randomized time off.
8. Single burst, no averaging, display off.
9. 100 averages, over range check and randomized time off.
10. Parameters measured: Rho, code domain power, RMS EVM, peak EVM, peak code domain error, frequency error, IQ offset and total channel power, display off.
11. Fast mode on, noise correction off, 10µs sweep, display off.
12. To preset condition accuracy, display off.
13. Parameters measured: Code domain power, RMS EVM, peak EVM, peak code domain error, frequency error, IQ offset and total channel power, display off.
14. Fast mode on, noise correction off, 10µs sweep, display off.
15. To preset condition accuracy, display off.
16. Display off, plots turned off, mean of 100 iterations, no frequency change, time includes GPIB transfer time (802.11b waveform with 540 chips).
17. Zero span, sweep time 100µs, binary data transfer, 501 data points, display off.
18. Display off, MEAS1;INIT;IMM;*WAI, MEAS2;INIT;IMM;*OPC.
2820 
RF Vector Signal Analyzer
400MHz to 4GHz or 6GHz

2820-GSM GSM, GPRS, and EDGE Signal Analysis Personality (Carrier ≤2.5GHz)

<table>
<thead>
<tr>
<th>Offset Frequency (kHz)</th>
<th>Carrier Frequency Fc (typical in parentheses)</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>400MHz ≤ Fc ≤ 1GHz</td>
</tr>
<tr>
<td>200</td>
<td>54 (35)</td>
</tr>
<tr>
<td>250</td>
<td>39 (40)</td>
</tr>
<tr>
<td>300</td>
<td>67 (68)</td>
</tr>
<tr>
<td>600</td>
<td>73 (74)</td>
</tr>
<tr>
<td>1200</td>
<td>78 (79)</td>
</tr>
<tr>
<td>1800</td>
<td>74 (75)</td>
</tr>
</tbody>
</table>

Relative Accuracy: ±0.7dB typical.

<table>
<thead>
<tr>
<th>Offset Frequency (kHz)</th>
<th>Carrier Frequency Fc (typical in parentheses)</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>400MHz ≤ Fc ≤ 1GHz</td>
</tr>
<tr>
<td>400</td>
<td>66 (67)</td>
</tr>
<tr>
<td>600</td>
<td>72 (73)</td>
</tr>
<tr>
<td>1200</td>
<td>78 (79)</td>
</tr>
<tr>
<td>1800</td>
<td>76 (77)</td>
</tr>
</tbody>
</table>

Relative Accuracy: ±0.7dB typical.

NOTES
1. Average of peak from each burst.
2. Nominal carrier power at RF input ≥−10dBm. Does not include level uncertainty due to inherent noise.
3. 1800kHz offset measured using 10kHz RBW. All other offsets measured using 30kHz RBW.

EDGE POWER AND MODULATION QUALITY

<table>
<thead>
<tr>
<th>Offset Frequency (kHz)</th>
<th>Carrier Frequency Fc (typical in parentheses)</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>400MHz ≤ Fc ≤ 1GHz</td>
</tr>
<tr>
<td>200</td>
<td>56 (38)</td>
</tr>
<tr>
<td>250</td>
<td>40 (41)</td>
</tr>
<tr>
<td>400</td>
<td>66 (69)</td>
</tr>
<tr>
<td>600</td>
<td>72 (75)</td>
</tr>
<tr>
<td>1200</td>
<td>75 (76)</td>
</tr>
<tr>
<td>1800</td>
<td>71 (72)</td>
</tr>
</tbody>
</table>

Relative Accuracy: ±0.7dB typical.

<table>
<thead>
<tr>
<th>Offset Frequency (kHz)</th>
<th>Carrier Frequency Fc (typical in parentheses)</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>400MHz ≤ Fc ≤ 1GHz</td>
</tr>
<tr>
<td>400</td>
<td>65 (67)</td>
</tr>
<tr>
<td>600</td>
<td>70 (72)</td>
</tr>
<tr>
<td>1200</td>
<td>74 (75)</td>
</tr>
<tr>
<td>1800</td>
<td>75 (76)</td>
</tr>
</tbody>
</table>

Relative Accuracy: ±0.7dB typical.

Displays: Power vs. time with time mask, ORFS due modulation, ORFS due to switching, EVM vs. time, symbols vs. time, constellation.

NOTES
1. Nominal carrier power at RF input ≥−10dBm. Does not include level uncertainty due to inherent noise.
2. 1800kHz offset measured using 10kHz RBW. All other offsets measured using 30kHz RBW.
# 2820 RF Vector Signal Analyzer

## MODEL 2820-CDMA2000-R: Reverse Link Signal Analysis Personality (Carrier ≤ 2.5GHz)

<table>
<thead>
<tr>
<th>Specification</th>
<th>Details</th>
</tr>
</thead>
</table>
| **CHANNEL POWER:** | Measurement Range: +33dBm to −70dBm (typical)  
Accuracy (1.2288MHz BW): ±0.6dB (typical). |
| **FREQUENCY ERROR:** | Frequency Error Measurement Range: ±3kHz (typical).  
Frequency Error Accuracy: ±10Hz (typical). |
| Rho (ρ) | Range: 0.7–1.0 (typical)  
Ceiling: > 0.9995  
Accuracy: ±0.005 (for ρ values >0.9). |
| **CODE DOMAIN POWER:** | Relative accuracy, for code channels ≥ 20dB of total power: ±0.3dB (typical). |
| **ADJACENT CHANNEL POWER:** | Dynamic Range: 70dBc @ 885kHz offset (typical).  
82dBc @ 1980kHz offset (typical).  
Relative Accuracy: ±0.5dB typical. |
| **OCCUPIED BANDWIDTH:** | Frequency Accuracy: ±5kHz (typical). |
| **SPECTRUM EMISSIONS MASK:** | Accuracy Relative to Carrier Power: <0.5dB. |
| **DISPLAYS:** | Code domain power, adjacent channel power with limits, occupied bandwidth with limit lines, conducted spectrum emissions with limits. |

### Notes
1. Carrier power at RF input ≥ 20dBm. Does not include level uncertainty due to inherent noise.

## MODEL 2820-WCDMA-D: Downlink Signal Analysis Personality (Carrier = 1800MHz–2200MHz)

<table>
<thead>
<tr>
<th>Specification</th>
<th>Details</th>
</tr>
</thead>
</table>
| **CHANNEL POWER:** | Measurement Range: +33dBm to −60dBm (typical).  
Accuracy (3.84MHz BW): ±0.6dB (typical). |
| **FREQUENCY ERROR:** | Frequency Error Measurement Range: ±3kHz (typical).  
Frequency Error Accuracy: ±10Hz (typical). |
| **RMS EVM:** | Measurement Range: 0%–25% (typical).  
Floor: 1.9% (typical).  
Accuracy: ±2%.  
Symbol EVM: 0.25%. |
| **CODE DOMAIN POWER:** | Relative Accuracy, for code channels ≥ 20dB of total power: ±0.3dB.  
Relative Accuracy: ±0.5dB typical. |
| **ADJACENT CHANNEL POWER:** | Dynamic Range: 63dBc @ 5MHz offset (typical).  
69dBc @ 10MHz offset (typical).  
Relative Accuracy: ±0.5dB (typical). |
| **OCCUPIED BANDWIDTH:** | Frequency Accuracy: ±20kHz characteristic. |
| **SPECTRUM EMISSIONS MASK:** | Accuracy Relative to Carrier Power: <1.5dB characteristic. |
| **DISPLAYS:** | Code domain power, adjacent channel power with limits, occupied bandwidth with limit lines, spectrum emissions with limits. |

### Notes
1. Applies when input signal is above −20dBm, with Expected Channel Power set equal to input power.
2. Measuring 802.11n MIMO signals can degrade the EVM floor by as much as 5dB.
Trigger and Synchronization Inputs and Outputs

TRIGGER SOURCES:
- Free run
- External
- Video
- Bus
- External arm using video trigger
- Bus arm using external or video trigger
- Latched External

TRIGGER DELAY:
-30 to +30 seconds

TRIGGER MODES:
- On measurement
- On acquire

EXTERNAL TRIGGER:
- Selectable on rising or falling edge of external input
- Input level TTL
- Minimum input pulse width required 50 ns (characteristic)

VIDEO TRIGGER MODES:
- Selectable on rising or falling signal edge
- Video level
- Pre-qualification mode level and time settings

SYNC OUTPUT MODES:
- Generate a sync pulse:
  - Off
  - Begin measurement
  - Start tune
  - Ready acquire
  - Start acquire
  - End acquire
  - End measurement

SYNC OUTPUT POLARITY SELECT:
- Sync out is on the falling or rising edge.

SYNC OUTPUT:
- TTL level
- Minimum pulse width 200 ns (characteristic)

EVEN SECOND CLOCK INPUT:
- External even second clock (TTL)

EVEN SECOND CLOCK OUTPUT:
- External even second clock (TTL)

1. Bus trigger and bus arm available only in channel power list mode.

GENERAL SPECIFICATIONS

POWER: 100VAC to 240VAC, 50/60 Hz (automatically detected), 150VA max.


CALIBRATION: Annual calibration cycle in system.

ENVIRONMENT (for indoor use only):
- 18° to 28°C specified operating, unless otherwise noted.
- 0° to 50°C operating survival, non-specified operation.
- -25°C to 65°C non-operating (AC power of) storage.

Altitude: Maximum 2000 meters above sea level.

Cooling: Forced air top, bottom, and side intakes and rear exhaust. For proper cooling in a rack, use Keithley Instruments 2910-RMK Rack Mount Kit.

DIGITAL INPUTS/OUTPUTS:
- 4 bits, TTL-compatible
- 10/100BT Ethernet, RJ45, LXI Class C, no auto MDIX
- RS-232
- IEEE-488.1 compliant
- Supports IEEE-488.2 common commands and status model topology
- USB full-speed

RF in/TG out:
- Type N connector

MECHANICAL VIBRATION AND SHOCK:
- MIL-PRF-2880 CL3 random vibration, 3 axes.
- Sin-Sweep test for resonances, 3 axes.
- MIL-STD-810F 516.5 paragraph, 4.5.7 procedure VI bench drop MIL-PRF-2880 CL3 random vibration, 3 axes

GENERAL MECHANICAL CHARACTERISTICS:
- Height: 3U (133mm) (5.25”)
- Width: Half-rack (213mm) (8.4”)
- Depth: 464mm (18.25”)
- Weight: 7.5kg (16.5 lbs.)

WARRANTY: 1 year.

SPECIFICATION NOTES

Specifications describe the instrument’s warranted performance. Typical and characteristic values are not warranted, but provide additional information regarding performance that you should expect from the Model 2820 and are provided to assist in application of the Model 2820.

SPECIFICATIONS (warranted performance):

Specifications indicate performance that is warranted. All units are warranted to meet these performance specifications under the following conditions:
- Ambient operating temperature of 18° to 28°C, unless otherwise noted.
- After a warm-up time of 30 minutes and self-calibration at ambient temperature.

TYPICAL (mean ± 3 standard deviations):

Typical indicates performance that units will meet under the following conditions:
- Ambient operating temperature of 25°C, unless otherwise noted.
- After a warm-up time of 30 minutes and self-calibration at ambient temperature.

This performance is not warranted.

CHARACTERISTIC (mean or expected value):

Characteristic indicates performance that a unit would be expected to exhibit under the following conditions:
- Ambient operating temperature of 25°C, unless otherwise noted.
- After a warm-up time of 30 minutes and self-calibration at ambient temperature.

This performance is not warranted.
2820

RF Vector Signal Analyzer
400MHz to 4GHz or 6GHz

Specifications are subject to change without notice.
All Keithley trademarks and trade names are the property of Keithley Instruments, Inc. All other trademarks and trade names are the property of their respective companies.